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Controllable etching of MoS₂ basal planes for enhanced hydrogen evolution through the formation of active edge sites

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ABSTRACT

The catalytic activity of molybdenum disulfide (MoS₂) is associated with active sites located along the edges, whereas the MoS₂ basal plane is regarded to be inert. However, it is a great challenge to develop a rational way for producing active edges efficiently. Herein, we report a novel, cost-effective top-down process in which we can create a high density of active edge sites on MoS₂ basal plane by selective steam etching. The results show that the etched structure is strongly sensitive to the temperature, which creates 1D nano-channels, 2D in-plane triangular pits and 3D vertical hexagonal cavities on the MoS₂ basal planes by elevating the temperature. The edge configuration is revealed to exhibit a distinct crystallographic orientation. Furthermore, we evaluate the corresponding enhanced electrocatalytic activity for the hydrogen evolution reaction (HER) by measurements of the single etched MoS₂ samples in an electrochemical microcell, where the Tafel slope decrease by 49%, confirming the increased density of active sites. In addition, the method is not limited to 2D materials in a flat geometry alone, but is also demonstrated on 0D MoS₂ particles by *in-situ* transmission electron microscopy. The steam etching reported here offers an alternative avenue to engineer the surface structures of MoS₂ facilitating the electrocatalytic applications of MoS₂ for hydrogen production.

1. Introduction

Owing to its low cost and high catalytic activity, molybdenum disulfide (MoS₂) has shown great promise as an alternative earth-abundant catalyst to replace platinum in the hydrogen evolution reaction (HER) used in electrochemical generation of hydrogen from water [1–5]. Experimental and theoretical studies have demonstrated that the catalytic activity arises entirely from the active sites located along the edges of MoS₂, while the unperturbed basal planes of MoS₂ are catalytically inert [3–7]. Many elaborate materials design strategies aimed at increasing the density of active sites at the surface of pristine MoS₂ have been reported, such as defect and substrate engineering [8–12], phase-engineering and nanostructure formation [13–18]. So far, most of the current approaches focus on synthesizing nanostructured MoS₂ by the bottom-up method, however, the top-down method may provide an alternative and facile process with high yield.

Chemical etching is already an effective top-down method to engineer the surface structures of materials through creation of fresh edges and nanoscale pores [19–21]. Recently, it has been reported that MoS₂ thin films could be thinned and etched by directly using H₂, XeF₂ and CF₄ et al.

[22–24]. However, the noxious reactants are involved; the formation of side-products and the complex etching process limits its practical applications. Herein, a simple and environmentally friendly steam treatment method has been developed with demonstrated ability to create various densities of MoS₂-edge sites within the inert basal planes of MoS₂ by controlling the temperature and vapor pressure of water. By this method, 1D nano-channels, 2D in-plane triangular pits and 3D vertical out-of-plane cavities are controllably etched on the planar surface of bulk MoS₂. Furthermore, the etching behavior is also demonstrated by time resolved *in-situ* TEM on curved, but still well-defined MoS₂ nanostructures resulting from technical catalyst preparation protocols. Finally, the catalytic activity is quantitatively evaluated by fabricating an electrochemical microcell based on individual steam etched MoS₂ flakes, which, by comparison with pristine MoS₂, demonstrated that the Tafel slope decrease by 49.7%. Finally, the simulation based on density functional theory confirms that the enhanced catalytic activity is not only due to the introduced edge sites, but also the edge-proximity MoS₂ basal plane, where the adsorption free energy of hydrogen atom on edge-closed MoS₂ basal plane is smaller than that of on pristine MoS₂ basal plane.

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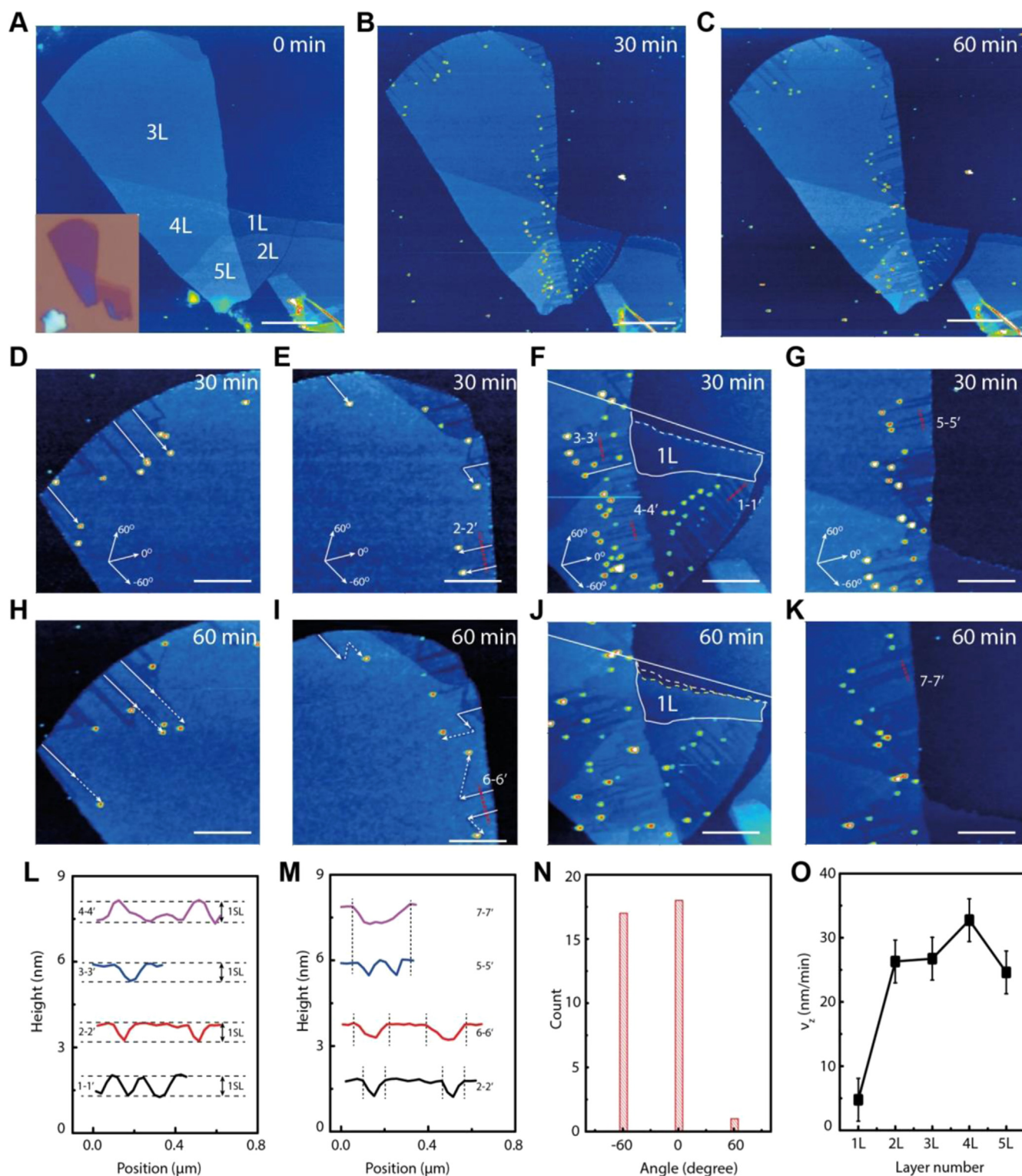


Fig. 1. 1D steam vapor etching of MoS₂. (A) The as-prepared 1–5 L MoS₂, the inset is the optical image. (B, C) The AFM images of 1–5 L MoS₂ after etching for 30 min and additional 30 min at 500 °C, respectively. (D–G) High-resolution AFM images from (B). (H–K) High-resolution AFM images from (C). The dash lines in (F) and (J) are the edges of monolayer MoS₂ edges before and after 30 min etching. (L) Line-profiles of the nano-channels corresponding to the red lines marked in (E) and (F). (M) Line-profiles of the nano-channels corresponding to the red lines marked in (E), (I), (G) and (H). (N) The distribution of the etching angle. (O) The etching speed on 1–5 L MoS₂. The scale bars in (A)–(C) are 2 μ m, and in (D)–(K) are 1 μ m. (For interpretation of the references to color in this figure legend, the reader is referred to the web version of this article.)

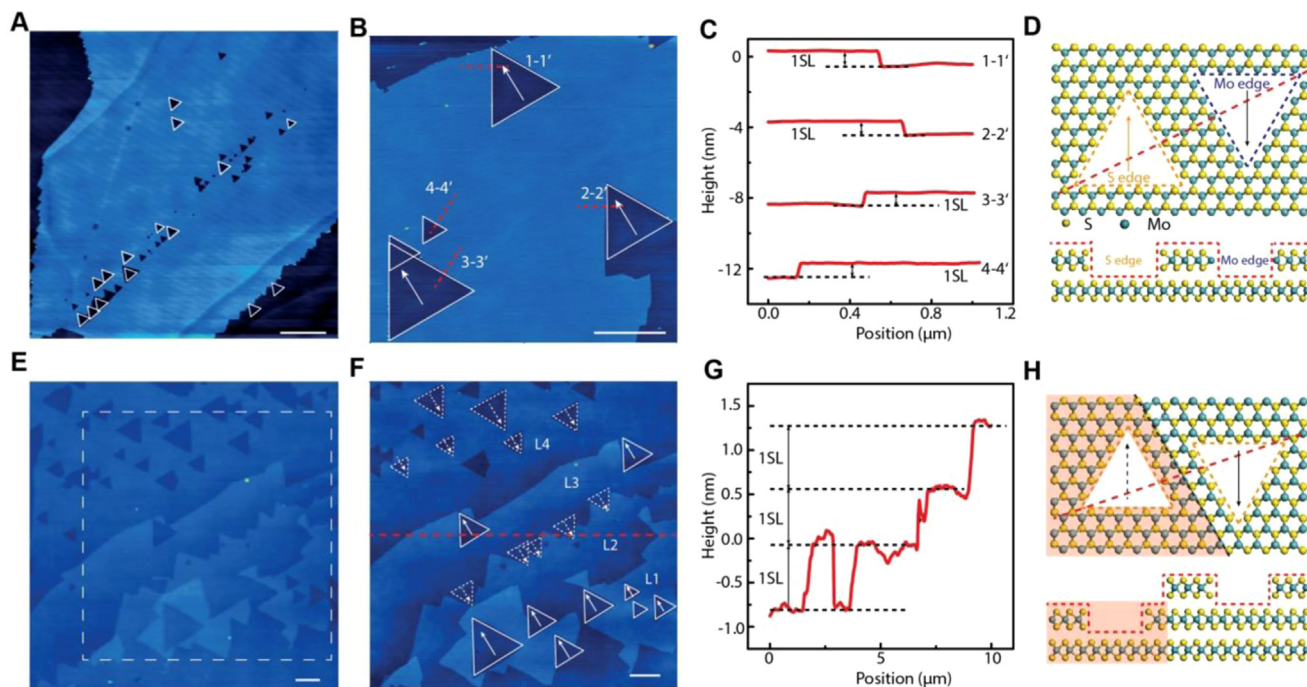


Fig. 2. 2D steam vapor etching of bulk MoS₂. (A) A typical AFM image of MoS₂ on SiO₂ after steam etching at 600 °C for 30 min (B) The high-resolution AFM image of the triangular pits. (C) Line-profiles corresponding to the dashed red lines marked in (B). (D) Schematic drawing of hexagonal lattice of the MoS₂ with one single layer depth triangular pits and the side-view along the dash line. (E) AFM image of the etched MoS₂ located on different layers. (F) zoom-in AFM image of the dashed white square in (E). (G) Line-profiles corresponding to the dashed red lines marked in (F). (H) Schematic drawing of two triangular pits on adjacent MoS₂ layers and the side-view along the dash line. The scale bars in (A), (B), (E) and (F) are 1 μm. (For interpretation of the references to color in this figure legend, the reader is referred to the web version of this article.)

2. Results and discussion

2.1. 1D steam vapor etching of MoS₂

The steam etching behavior is first studied on thin (1–5 L) MoS₂ flakes, which are deposited on SiO₂ surface through mechanical exfoliation. The number of layers of MoS₂ flake (1–5 L indicated in Fig. 1A) is confirmed by the optical contrast from an optical microscope (the inset of Fig. 1A), the height from atomic force microscopy (AFM) (Fig. S1) and Raman spectra (Fig. S2) [1,2]. The steam vapor is mixed with Ar carrier gas at ambient temperature and the gas mixture is then introduced into the hot furnace. The MoS₂ sample is exposed to the reacting gas at 500 °C for 30 min and 60 min which resulted in the surface morphologies of the MoS₂ flakes shown in Fig. 1B and C, respectively. Here, our AFM images show that a number of 1D nano-channels have been formed from the edge and inwards on the exposed basal planes of the MoS₂ flake. The uniform direction of the nano-channels implies that the steam vapor etching follows an anisotropic behavior. The etching process initiates at the MoS₂ perimeter and along certain crystallographic directions. No etching is observed when the temperature is below 500 °C (Fig. S3), suggesting that the present etching mechanism is different from that using the air exposure [25–28]. Interestingly, the high-resolution AFM images (Fig. 1D–K) also show that a nanoparticle with approximate size equal to the width of the nano-channel is located at the end position of each etched channel. Although the chemical nature of this nanoparticle is not determined, we speculate that it is molybdenum oxide formed from the reaction of MoS₂ with H₂O during etching [29]. The position of the nanoparticle at the reaction front of the etched channel indicates that it may serve as a catalyst steering and facilitating the etching process. The line-profiles in Fig. 1L show that the depth of the 1D nano-channel is 0.7 nm, in agreement with the thickness of one single-layer (SL) MoS₂. The widths of the nano-channels are widened after etching for additional 30 min (Fig. 1M), but the depth of the nano-channels remained unchanged.

This phenomenon is also observed on another MoS₂ flake (see Fig. S5) meaning that the MoS₂ edge can also be etched without the help of molybdenum oxide nanoparticle. It should be notable that the etching speed with the help of molybdenum oxide nanoparticle (~ 25 nm/min, see Fig. 1O) is much higher than the etching speed without the help of molybdenum oxide nanoparticle (~ 1.2 nm/min, see Fig. S5) which clearly identify its role in the steam etching process. The relative orientation of the nano-channels along their growth direction within a single layer is separated by ± 60° degree in accordance with the six-fold symmetry of MoS₂. Furthermore, Fig. 1E and I and also Fig. 1N show that the nano-channels can change their direction during etching (see Figs. S5 and S6) while obeying the six-fold symmetry, which indicates that the etching mechanism follows the low-index crystallographic orientations of the MoS₂ lattice. The channel formation indicates an anisotropic etching behavior. This morphology is compatible with the preferential formation of low-energy edge terminations of MoS₂, referred to as either S-edges or Mo-edges, known to be particularly active in hydrogen evolution [3,30]. The etching speed is comparable for all layers of MoS₂ except 1 L MoS₂ (Fig. 1O), indicating that there is no obvious correlation between the etching speed and the thickness of the MoS₂. A noteworthy exception is that the area of 1 L is decreasing with speed of 5 nm/min, however, that no obvious channels are formed on 1 L MoS₂ during the etching process (Fig. 1F and J). The different etching behavior is evidently caused by a substrate effect. We speculate that a charged impurity on the SiO₂ substrate could pin the molybdenum oxide catalyst and thus impede the etching within the first layer [31]. Thus, we have demonstrated that MoS₂ can be etched by steam and form nanochannels on MoS₂ with crystalline edges, in a similar way as etching of graphene to form nanoribbon [32].

2.2. 2D steam vapor etching of MoS₂

A different etching morphology develops on the few layer MoS₂ sample (Fig. S7) and bulk MoS₂ (Fig. 2 and Fig. S8) when the

temperature increases further to 600 °C. Instead of nano-channels, small triangular pits are formed within the exposed basal planes of MoS₂, which can be attributed to anisotropic steam etching initiated at intrinsic structural defects. Compared with the sample produced at lower temperature etching, the nanoparticles that control the etching behaviors have disappeared. The time-resolved 2D etching (Fig. S9) directly proves that the steam etching follows a layer-by-layer etching behavior. The uniform orientation of the triangular pits and their single-layer (SL) height (Fig. 2B and C) indicates that the steam etching results in the formation of low-index edges embedded within the MoS₂ layer [25,26]. The single-layer triangular MoS₂ pits in Fig. 2D can in principle adopt two different low-index edge orientations, either S-edge or Mo-edge. All the triangular pits (Fig. 2A) have the same orientation within the same MoS₂ layer, indicating that the pits formed in the same MoS₂ layer have same edge configuration. However, we cannot determine the particular edge structure. From the cross section model obtained by removal of triangular patches from a single layer in Fig. 2D, the Mo atom on the Mo-edge (10 $\bar{1}$ 0) has unsaturated coordinated S atoms, comparing with the Mo atom on the S-edge ($\bar{1}$ 010) which retains its coordination to size sulfur. The triangular pits observed in this study are assumed to be S-terminated edge [33,34], while there is some controversy. Fig. 2E and F show AFM images of the etched MoS₂ on different MoS₂ layers. The line profile (Fig. 2G) clearly reveals the height of the MoS₂ step and the depth of the triangular pits to be a single-layer. The triangular pits on adjacent layers show opposite orientations, but have the same S-edges (Fig. 2F) because the AB-stacking of bulk MoS₂ places the S atoms of the top layer above the Mo atoms of the underlying layer, equivalent to an alternating 60° rotation of in-plane crystallographic directions between layers. According to the schematic drawing in Fig. 2H, triangular pits with opposite orientation on adjacent layers therefore have the same edge termination.

2.3. 3D steam vapor etching of MoS₂

The MoS₂ surface morphology further develops when the etching temperature is increased to 700 °C. The resulting morphology now reflects tens-of-layers deep cavities with an apparent hexagonal outline as shown in Fig. 3A (and also see Fig. S10 and S11). A typical high-resolution AFM image of a hexagonal cavity (Fig. 3B) shows that the cavity is in fact composed of a larger triangular pit in the topmost layer which transitions into a hexagonal shape for deeper layers. The correlated line-profile (Fig. 3C) through the cavity directly demonstrates that the step height is always an even number of MoS₂ layers in vertical direction, except the topmost layer (1SL) and the bottommost layer (7SL) of the cavity. For the formation of the hexagonal cavity, firstly, a triangular pit with S-edge will be etched in the top MoS₂ layer (labeled as E_{1-S}) (Fig. 3D), and then a small triangular pit formed in the bottom MoS₂ layer with the same S-edges (Fig. 3E, labeled as E_{2-S}), where the pit orientation is opposite with the one formed in top layer. While the etching goes on, the E_{2-S} edges will keep etching and the bottom triangular pit grows bigger, and finally stops (Fig. 3F). The etching of E_{2-S} edges is then prevented by the top E_{1-S} edges to form vertical (S-edge/Mo-edge, E_{1-S}/E_{2-Mo}, as labeled in Fig. 3G) structures. Thus, the hexagonal pit on second layer will initiate the etching behavior to form deeper 3D pit with new structures (in-plane hexagonal pit with alternated S-edges and Mo-edges; out-of-plane with S-edge/Mo-edge unit). The hexagonal cavity morphology arises due to the 2H-stacking sequence of MoS₂ indicating that Mo- and S-edge are aligned alternately. The alternating edge termination of a complete 3D MoS₂ cavity is illustrated in Fig. 3h, which is drawn according to the Fig. 3C. The detailed discussion of the edge sequence of the hexagonal cavity is shown in Section S1. In order to shed light on the detailed 3D steam etching mechanism, time-resolved AFM was performed on MoS₂ flakes, as shown in Fig. S12. Interestingly, the etching direction primarily goes towards into the surface at this temperature, which is different from the etching direction of 2D layer-by-layer etching. To further reveal the

direction of the etched MoS₂ edges, we recorded the atomic structure on the basal plane by lateral force microscopy as shown in Fig. S13. It can be clearly seen that the edges on etch pit are parallel to the close packed directions on the MoS₂ basal plane, showing that the edges must be either the Mo or S edges. Significantly, the atomic resolution images recorded from four neighbor layers have the identical FFT patterns, which suggest that the etched edges on different layers have the same zigzag configuration. Comparing with other chemical etching, such as O₂ and H₂ [22–24], the etching behavior on MoS₂ by H₂O steam vapor is fairly sensitive to temperature, which allows to create 1D nano-channels, 2D in-plane triangular pits and 3D vertical hexagonal cavities nanoscale morphology by varying the etching temperature (per ~ 100 °C).

2.4. In-situ TEM imaging of etching MoS₂

The AFM results show that steam etching of MoS₂ flakes in the range from 500 to 700 °C can be used to selectively control the formation of three widely different surface morphologies, which however share the property that new active edges are created. The resulting morphologies in the temperature range reflect a complex interplay between preferential etching along low-index crystallographic directions in MoS₂ and mobility of vacancies, which leads to equilibrium shapes formed within the MoS₂ layers. We further explored steam etching of MoS₂ nanoparticles by means of *in-situ* transmission electron microscopy (TEM). The MoS₂ were synthesized in the microscope by thermally decomposing ammonium heptamolybdate ((NH₄)₆Mo₇O₂₄) to produce MoO₃ nanoparticles, which were subsequently sulfided in the microscope. The resulting nanoparticle shells consisted of concentric MoS₂ layers with a core of reminiscent molybdenum oxide, resembling the fullerene-like multi-layer MoS₂ nanostructures previously reported by Tenne et al. [35]. Fig. 4A shows that the as-prepared nanoparticles expose mainly the MoS₂ (002) basal plane reflecting a low availability of edge sites so such structures are expected to be poor HER catalysts. However, edge sites can be formed in these layers by exposure to steam at elevated temperatures. The steam etching was monitored by acquisition of a time-resolved series of TEM images of the MoS₂ nanostructures *in situ* during exposure to 1 mbar of H₂O at 700 °C. Fig. 4B–D show that etching initiates at the outer MoS₂ layer (Fig. 4B) by removal of part of the MoS₂ layer, so that a pair of edge appears in the projected images (Fig. 4B). Thus, these observations show that the steam etching is a viable method to sculpture surface morphology of nanomaterials with curved MoS₂ layers as well and therefore offers a way to increase the abundance of edge sites in MoS₂ materials of relevance for heterogeneous catalysis.

2.5. Hydrogen evolution on MoS₂ basal plane

We quantify the enhancement effect of the HER activity associated with the multiplication of active sites on the steam etched MoS₂ flakes. The sample is etched at 700 °C, and its surface is further checked by AFM before device fabrication. The HER activity is investigated using a three-electrode configuration with Pt wire as the counter electrode, micro Ag/AgCl electrode as the reference electrode, and one gold pad connecting with the single individual MoS₂ flake as the working electrode, as shown in Fig. 5A and B. The sample except for the MoS₂ basal plane is fully covered by PMMA to ensure that the measured activity originates only from the exposed area (white-dashed square in Fig. 5C). The exposed window on the MoS₂ basal plane is prepared by electron-beam lithography (see Experimental section). Typical polarization curves are measured in the microcell configuration on pristine and etched MoS₂, respectively, as shown in Fig. 5D. It can be seen that the onset potential is 492 mV at a current density of 5 mA/cm² for the pristine sample whereas the onset potential drops to 316 mV for etched MoS₂ sample. The electrochemical measurement implies that the same current density can be obtained at a much lower potential after steam

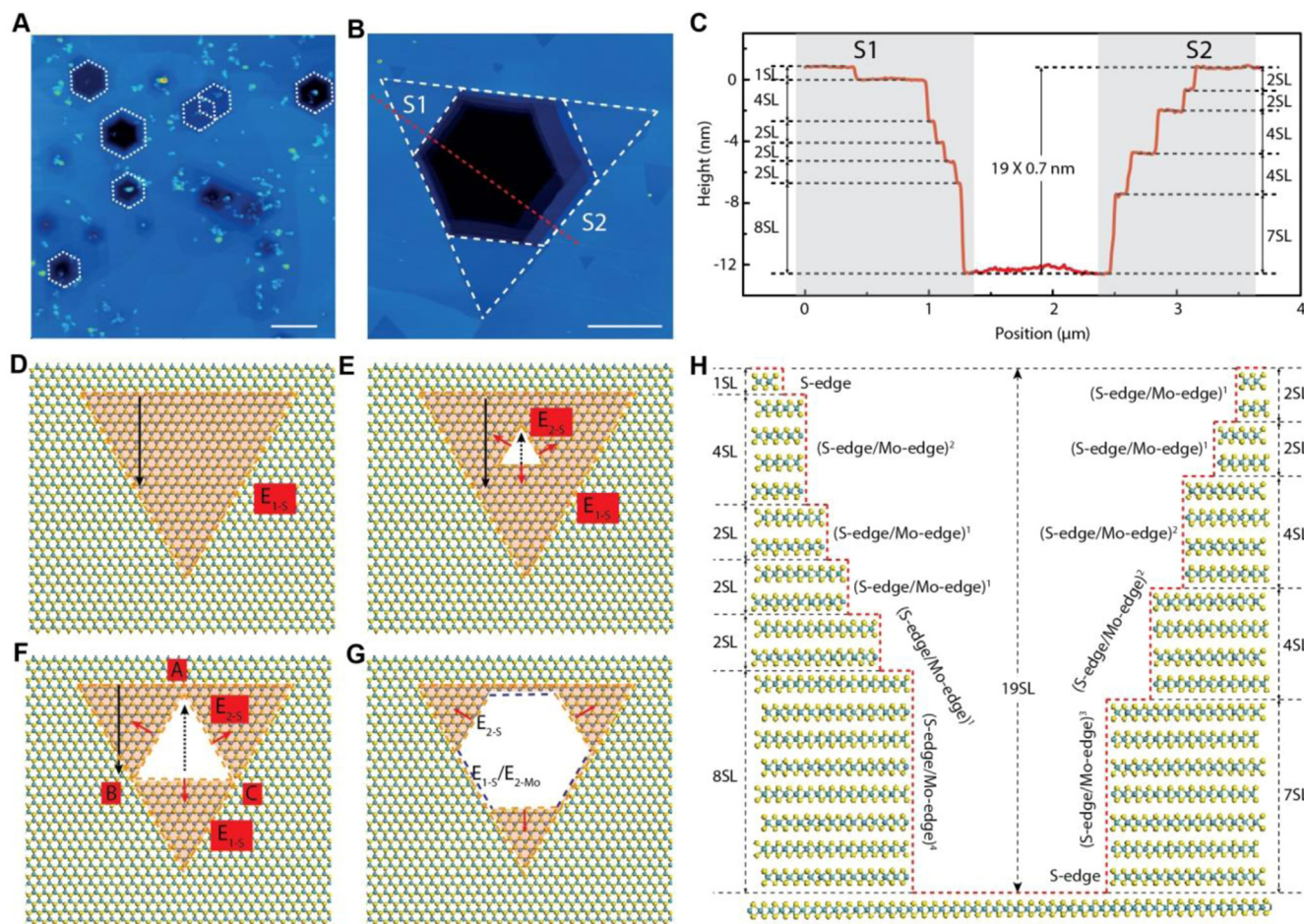


Fig. 3. 3D steam vapor etching of MoS₂. (A) A typical AFM image of bulk MoS₂ after steam etching for 30 min at 700 °C. (B) A typical high-resolution AFM image of the out-of-plane cavity. (C) Line-profile corresponding to the dashed red line marked in (B). (D–G) The schematic drawing evolution to form hexagonal pits on two layers MoS₂. (H) The schematic drawing the section according to (C). The scale bars in (A) and (B) are 1 μm. (For interpretation of the references to color in this figure legend, the reader is referred to the web version of this article.)

etching. It is noticed that platinum counter electrode may give influence on the polarization curve after cycling voltammetric sweeping with large scanning speed (hundreds mV/s) [36]. By reducing the scanning speed and the number of cycle, the platinum contamination can be dramatically reduced. In this work, the polarization curve is

obtained with very low scanning speed (5 mV/s). The AFM image and EDS spectrum of the MoS₂ flake after hydrogen evolution reaction (see Fig. S15) indicate that no detectable platinum particle is formed confirming the electrochemical polarization current is originating from the catalytic property of MoS₂ itself. Meanwhile, the corresponding Tafel

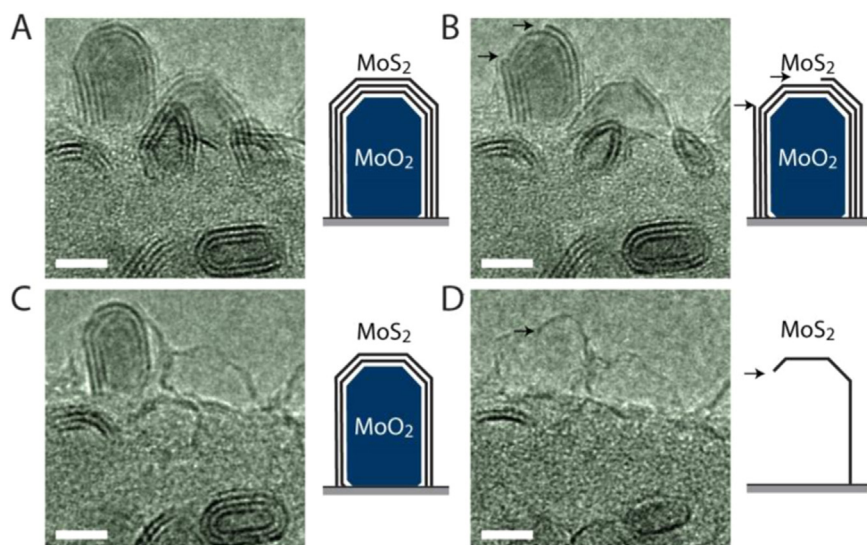


Fig. 4. Time-resolved *in-situ* TEM imaging of MoS₂ during exposure to steam. (A) TEM image and sketch of as-prepared MoO₂:MoS₂ nanoparticles. (B–D) Time-resolved TEM images of the MoS₂ nanoparticles after 7 min (B), 12 min (C) and 17 min (D) exposure to 1 mbar of H₂O at 700 °C. Sketches are included to guide the eye pinpointing the steam-induced edge formation. The scale bars are 5 nm. The role of electron illumination is shown in Fig. S14.

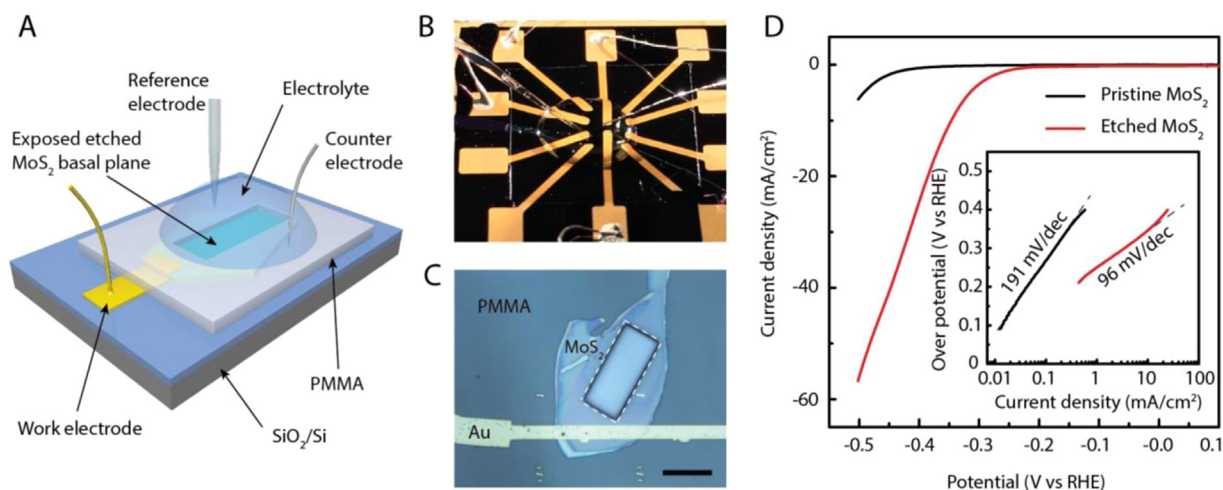
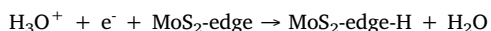


Fig. 5. Hydrogen evolution measurements on pristine and etched MoS₂ basal plane. (A) Schematic of the setup showing a single gold pad connected with a MoS₂ flake used as the working electrode. Pt wire and micro Ag/AgCl electrodes are used as counter and reference electrode, respectively. The whole sample is covered with PMMA except a window on the MoS₂ basal plane to ensure that the activity is only originating from the exposed area. (B) Photography of the electrochemical microcell. (C) Optical microscope image of the microcell where a window (white-dashed square) was exposed on MoS₂ basal plane. The scale bar is 20 μm . (D) The typical polarization curves measured from pristine and etched MoS₂ based microcell in 0.5 M H₂SO₄ with scan ratio of 5 mV/s, and the inset is the corresponded Tafel plot.

plots are shown inset in Fig. 5D, showing a 49.7% decrease of the Tafel slope (from 191 mV/dec to 96 mV/dec), indicating an enhanced catalytic activity [8,9,22,37–39]. A previous study demonstrates the influence of contact resistance on electrochemical performance [11]. To eliminate the contact resistance influence, many four-terminated devices on pristine and etched MoS₂ flakes are fabricated, and the contact resistances are evaluated, as shown in Fig. S16. The contact resistance on pristine and etched MoS₂ flakes are similar with each other in the range from 10^{-1} to 10^0 k Ω mm, which is much lower than the critical contact resistance (10^1 to 10^2 k Ω mm) indicating that the enhanced catalytic activity is originated from the etched edges rather than the variation of contact resistance [11]. The introduced edges by steam etching are able to modulate its surface structure and thus change the electronic properties of the surface, which allow tuning the reaction barriers effectively [40]. A smaller Tafel slope indicates a faster increase of the HER rate with the decrease of over-potential. Three steps (discharge, combination and desorption steps) have been proposed for converting H⁺ to H₂ on the catalyst surface, in which the first discharge step



is the key rate-determining step when the Tafel slope is higher than 120 mV/dec [8,9,22,37–39]. In this study, the observed 191 mV/dec Tafel slope on pristine MoS₂ flake is even higher than CVD-grown MoS₂ (150–160 mV/dec), which may be attributed to that the CVD-grown MoS₂ has some S vacancy in CVD-grown MoS₂ [9,22]. The higher Tafel slope in our case show that the proton transfer in the discharge step is the limiting step resulting from its very low abundance of edge sites [38]. In steam-etched MoS₂ flake, the free energy barrier of the discharge step is reduced to be comparable with that of the following desorption or combination step, resulting in a significant drop of the slope to 96 mV/dec. The improved Tafel slope originates from the generated MoS₂-edges on MoS₂ basal plane which will effectively decrease the activation energy [8,9]. Each surface structure (edges, corners, steps and kinks) may be able to modulate its surface structure and thus change the electronic properties of the surface, which may tune the reaction barriers effectively [40]. Thus, the improved performance should be attributed to the creation of fresh cavities with huge amounts of edges, corners and steps after etching.

2.6. DFT calculations on etched MoS₂

The electrocatalytic splitting of water by the microcell technique quantitatively demonstrates the enhanced catalytic activity of etched MoS₂, suggesting that steam vapor etching is a promising candidate method to improve catalyst performance. The interesting MoS₂ nanostructures etched by steam vapor etching will expose both Mo edges [30]. To obtain fundamental insights on the potential activity of the etched S-edges in the electrocatalytic reaction, we employed density functional theory (DFT) calculations to investigate the adsorption free energy of H atoms (ΔG_{H^*}) at different sites of the S-edge terminated etched triangle in the MoS₂ model structures as shown in Fig. 6. ΔG_{H^*} has been widely considered to be a useful indicator for the catalytic activity and a ΔG_{H^*} value close to zero generally suggests high catalytic activity [29,41]. Here, a positive ΔG_{H^*} suggests the hydrogen form a strong bond to the catalyst, and the negative ΔG_{H^*} implies no efficient bonding to the catalyst. Both of them will lead to inefficient hydrogen release and proton–electron transfer resulting in the decreasing of catalytic activity. As shown in Fig. 6B, the ΔG_{H^*} for basal plane sites on pristine MoS₂ is 1.24 eV, indicating its inertness, in line with previous simulations [42]. Significantly, one can see that the ΔG_{H^*} for etched MoS₂ decrease to -0.48 eV, which indicates bonding of H with a value much closer to zero compared to pristine MoS₂. Furthermore, the site dependence of ΔG_{H^*} on etched MoS₂ are shown in Fig. 6C and the adsorption site is shown in Fig. S17. As can be seen, along the etched edge from P2 (-0.74 eV) to P6 (-0.61 eV), ΔG_{H^*} has no obvious change, but always closer to zero compared to pristine MoS₂, suggesting the etched edge itself is active. ΔG_{H^*} values on S atoms at the corner (P1) is $+1.17$ eV, suggesting no hydrogen adsorption at the corner of the MoS₂ pit. Moreover, away from the etched edge (P7 to P10), the ΔG_{H^*} will increase from $+0.59$ eV (P7) to $+1.11$ eV (P10), which is still better than ΔG_{H^*} of pristine MoS₂. It should be noted that the ΔG_{H^*} will increase and tend to the value of pristine MoS₂. This suggests that the etched pit not only active the etched edge, but also active the nearby area, attributing to the modulated electronic structure.

In addition, electronic structure calculation is performed to analyze origin of the site dependence of ΔG_{H^*} on etched MoS₂ because the catalytic property of a catalyst is determined fundamentally by its

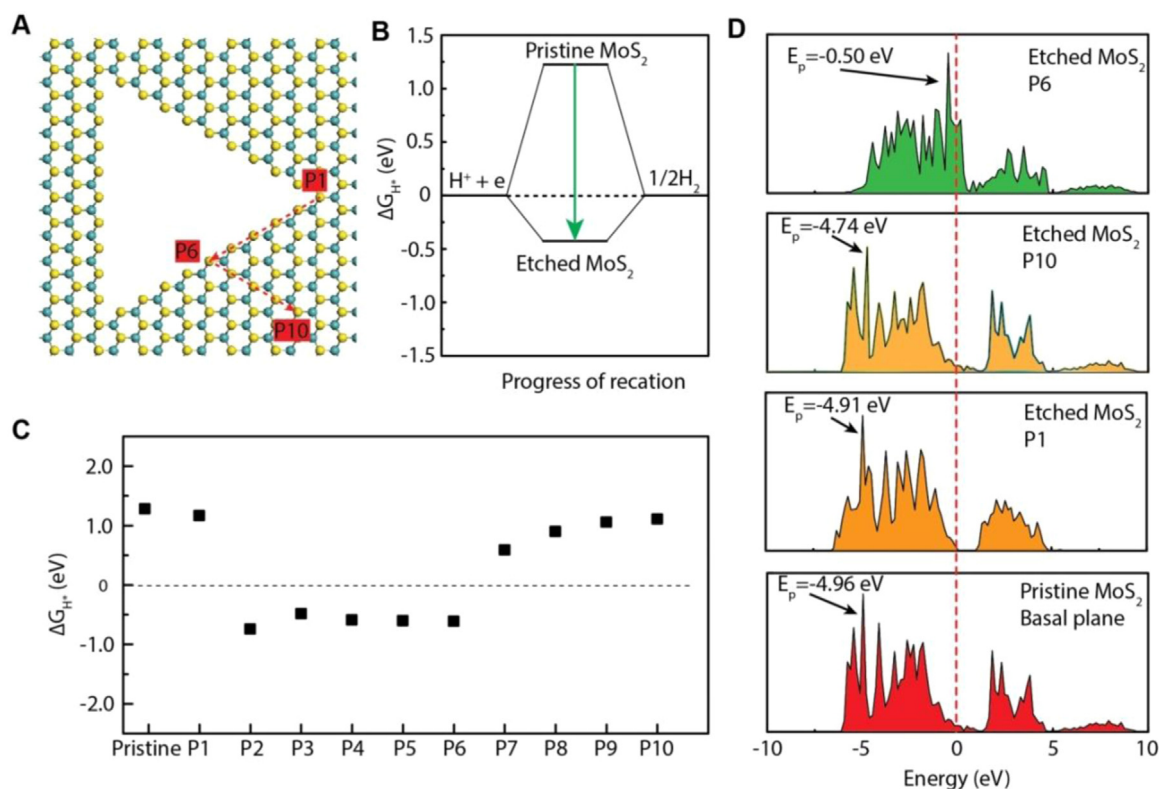


Fig. 6. DFT calculation on etched MoS₂. (A) The etched MoS₂ model, where the hydrogen atom is adsorbed on different sites. (B) The free energy diagrams for pristine and etched MoS₂. (C) The HER free energy for different hydrogen atom adsorbed sites. (D) Projected density of states (PDOS) plots of 2p orbitals for S atom on basal plane and P1, P6 and P10 adsorption sites of etched MoS₂. The red dash line represents the Fermi level. (For interpretation of the references to color in this figure legend, the reader is referred to the web version of this article.)

electronic structure [40]. The most commonly related electronic band structure is the valence band, and the higher the valence band position (E_p) indicates a stronger the H^* adsorption strength [43,44]. Therefore, the projected density of states (PDOS) of various active sites (P1–P10 and basal plane) were calculated illustrating in Fig. 6D. As seen, E_p for S atom on the etched edge (P6) is -0.50 eV, which is much larger than that of E_p for S atom on the basal plane (-4.96 eV). The higher energy level of E_p suggests a higher energy level of the anti-bonding states and a lower occupancy, which will induce a stronger interaction between adsorbed hydrogen atom and catalyst site (S atom) [43,44]. Therefore, the highest energy level for P6 means the strongest adsorption of hydrogen and lowest values of ΔG_{H^*} . Moreover, the E_p for S atom is -4.91 eV and -4.71 eV, corresponding to S atom on P1 (corner) and P10 (away from edge), respectively. The higher energy level of P1 and P10 compared with that on basal plane indicates a well adsorption and an improved ΔG_{H^*} .

3. Conclusion

In summary, a simple and environmentally friendly steam treatment method has been developed with the demonstrated ability to create various densities of active edge sites on the inert basal planes of MoS₂. Different edge morphologies, represented by 1D nano-channel, 2D in-plane triangular pit and 3D out-of-plane cavity surface structures could be created through controlling the etching temperature during the steam etching process. A high amount of created active edges on MoS₂ basal plane effectively decrease its surface free energy barrier and improve its catalytic activity, which is quantitatively studied by fabricating an electrochemical microcell containing steam etched single MoS₂ flakes. Thus steam etching offers a straightforward and general process to nanoengineer pristine MoS₂ materials for enhanced catalytic operation.

4. Experimental section

4.1. Sample preparation and steam vapor etching of MoS₂

Few-layer MoS₂ flakes were deposited on the Si substrate with a 300 nm SiO₂ film by mechanical exfoliation of bulk MoS₂ crystal. Both bulk MoS₂ and transferred few-layered MoS₂ were then placed in a quartz tube, where highly purified Ar (1000 sccm) was flowed for 30 min to exclude the effect of air. After that, the MoS₂ samples were then annealed at different temperatures in water steam, which was carrier into the quartz tube by Ar (500 sccm). During the whole etching process, the total pressure was kept at atmospheric pressure and water steam is assumed to be present at its vapor pressure at room temperature (~ 23 mbar). When the etching process finished, the MoS₂ samples were cooled to room temperature and taken out for analysis.

4.2. Raman and AFM characterizations

The Raman spectroscopy experiments were carried out with 514 nm and 1.0 mW laser excitation (Renishaw inVia Raman Spectroscopy, Sweden). All AFM images were captured by a commercial Dimension Icon AFM (Bruker, Santa Barbara, USA) in tapping mode with ultrasharp probes (OMCL-AC160TS-C2, Olympus, Japan) in air. Analysis of AFM images was done with Scanning Probe Image Processor software (SPIP™, Image Metrology ApS, Lyngby, Denmark). The atomic resolution edge configuration was investigated by lateral force microscopy, which is conducted on MultiMode-8 with soft probes (MSNL-10, 0.6 N/m).

4.3. Transmission electron microscopy of steam-etching of MoS₂ nanoparticles

The experiments have been performed using a Philips/FEI Company

CM300 FEG-ST transmission electron microscope equipped with a differential pumping system [45]. In the experiments, ammonium heptamolybdate, $(\text{NH}_4)_6\text{Mo}_7\text{O}_{24}$ was loaded onto a FEI NanoEx heating device and heated in the microscope base vacuum to decompose the precursor into MoO_3 nanoparticles [46]. The MoO_3 was subsequently sulfided by exposure to 1 mbar of 10% H_2S in H_2 at 700 °C for 40 min followed by 800 °C for 35 min in the electron microscope. For steam etching, the MoS_2 nanostructures were exposed to 1 mbar of H_2O . Prior to vapor exposing the sample, the water was cleaned by successive freeze–pump–thaw cycles of the water container until contaminants were absent in mass spectrometry of the gas in the container. The mass spectrometer was mounted on the second differential pumping stage of the electron microscope [45]. To monitor the MoS_2 nanostructures during steam exposure, the microscope was operated at a primary energy of 300 keV and at an electron dose rate of 150 electrons $\text{\AA}^{-2} \text{s}^{-1}$. Images were acquired with a charged coupled device (CCD) camera (Tietz F114) with the projection system of the microscope corresponding to an effective pixel size of 0.07 nm. At each time step and position, a series of 5 successive images was acquired with a CCD exposure time of 1 s. The images in each series were post-aligned using cross-correlation and summed to a final image with improved signal-to-noise ratio. The final images are represented as a direct representation of the CCD current output in a monochromatic green color scale. Additionally, the image contrast and brightness have been linearly adjusted.

4.4. Single MoS_2 flake based microcell fabrication and electrocatalytic hydrogen evolution reaction

MoS_2 flakes were prepared on SiO_2/Si by mechanical exfoliation, and further treated at 700 °C in steam. After further check of the etched pattern by AFM, poly(methyl methacrylate) (PMMA) were spin-coated on its surface and then baked at 100 °C for 5 min. Then a knife was used to cut the PMMA with small pieces with the etched MoS_2 flake is inside. The small PMMA/ MoS_2 pieces could be quickly released by immerse in 1% HF solution. After washing them several times in DI water, the small PMMA/ MoS_2 pieces were transferred to the center of the new SiO_2/Si substrate which has been deposited with 10 gold contact pads via metal mask. The small piece makes it easy to place at the correct site at the center before drying. After a bake at 150 °C for 5 min, the PMMA could be removed by warm acetone. A new PMMA layer was spin-coated on the sample at 4000 rpm and then baked at 180 °C for 2 min. Electron-beam lithography was employed to design microelectrodes patterns to connect the MoS_2 flake with the closed contact pads. Each contact pad is connected to only one MoS_2 flake and thus each flake can be tested separately. Once the MoS_2 flakes were connected, a second electron-beam lithography process was employed to expose the basal plane of MoS_2 and cover the edges of MoS_2 flake and the electrodes. To fully cover them, PMMA A11 was spin-coated on the sample at 4000 rpm for 60 s, and baked at 180 °C for 5 min. Its thickness is about 2 μm . And then, to eliminate the charge effect, conductive polymer was spin-coated on it at 2000 rpm for 60 s and baked at 90 °C for 2 min. The window was opened on the MoS_2 flake by e-beam lithography with 300 $\mu\text{C}/\text{cm}^2$ dose. More attention was devoted to make sure that no gold and none of the original edges of MoS_2 flakes were be exposed to the electrolyte.

After the sample was baked at 180 °C for 10 min, the HER measurement was performed. Linear sweep voltammetry with a scan rate of 5 mV/s was conducted in 0.5 M H_2SO_4 solution using a Pt wire as the counter electrode. The micro reference electrode was calibrated for the reversible hydrogen potential, where $E(\text{vs RHE}) = E(\text{vs Ag/AgCl}) + 0.197 \text{ V}$. Before measurement, H_2SO_4 solution was degassed using pure Ar gas.

4.5. Computational details and models

Geometry optimization, total energy calculations and electronic structure were performed by using first-principle calculations within the framework of density functional theory (DFT), as implemented in the plane wave set Vienna ab initio Simulation Package (VASP) code. The Perdew-Burke-Ernzerhof (PBE) functional within the generalized gradient approximation (GGA-PBE) was used to model exchange correlation energy. The projector augmented wave (PAW) pseudo-potentials were used to describe the interaction valence electron and ionic cores. The kinetic energy of 500 eV cut off was set in all calculations. A Gaussian smearing with $\sigma = 0.05 \text{ eV}$ to the orbital occupation is applied to broaden the Fermi level for accurate electronic convergence, whilst a tetrahedron method with Blöchl corrections was employed for the accurate electronic structure calculations. To simulate pristine and etched MoS_2 , a $12 \times 12 \times 1$ supercell was used and a vacuum slab of 10 \AA was inserted in z direction to prevent interaction between two neighboring surfaces. Geometry optimizations were performed by using the BFGS algorithm with a $1 \times 1 \times 1$ k-mesh until the maximum force component of the system converges to 0.02 eV/ \AA , while a $2 \times 2 \times 1$ k-mesh is adopted for total energy and electronic structure calculations. The adsorption free energy of hydrogen, ΔG_{H^*} , is a good descriptor to estimate the activity of hydrogen evolution reaction, which is determined in the formula: $\Delta G_{\text{H}^*} = \Delta E_{\text{H}^*} + \Delta E_{\text{ZPE}} - T\Delta S$ [29,47]. In the formula, $\Delta E_{\text{H}^*} = E_{(\text{surface} + \text{H}^*)} - E_{\text{surface}} - 1/2E_{\text{H}_2}$, where $E_{(\text{surface} + \text{H}^*)}$ and E_{surface} are total energy of the surface model with and without H^* adsorption, respectively. E_{H_2} is the energy of a single H_2 molecule isolated in vacuum. ΔE_{ZPE} is the zero-point energy difference between the adsorbed state of the system and the gas phase state. ΔS_{H} is the entropy difference between the adsorbed state of the system and the gas phase standard state.

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Appendix A. Supporting information

Supplementary data associated with this article can be found in the online version at <http://dx.doi.org/10.1016/j.nanoen.2018.04.067>.

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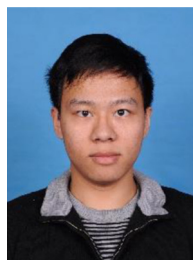
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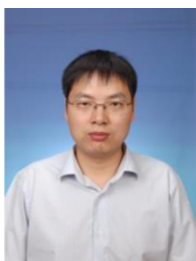
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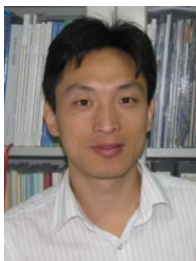
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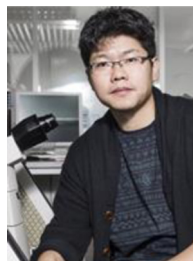
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